

IAP6 Rec'd PCT/PTO 18 AUG 2006

- 1 -

## Method and Device for Measuring Ultrahigh Vacuum

The invention relates to a method and a device for measuring ultrahigh vacuum and, more particularly, to a method for measuring ultrahigh vacuum with an ultrahigh-vacuum cold cathode pressure gauge, and to an ultrahigh-vacuum, cold cathode pressure gauge. The pressure gauge of the invention operates at a voltage that varies with pressure in such a way that the ion current flow is maintained at its maximum value at all times. The maximum current is more stable and is directly proportional to the pressure. That is why, by measuring said current, information about the pressure is obtained. Owing to its linear, characteristic, which is a consequence of the varying voltage, the cold cathode pressure gauge is more accurate in measuring pressure. Due to its operation at maximum level, in turn, it exhibits better sensitivity.

## 1. Technical Problem

For measuring pressure in ultrahigh vacuum, ionization gauges are utilized, the operation thereof being based on the measurement of the ion current ( $I$ ) on the cathode, said ion current depending upon pressure ( $p$ ). The main problem with all prior art pressure gauges consists in that the dependency of current upon pressure is non-linear. The ionization of the molecules is brought about by collisions with electrons, whereby an electrical discharge is initiated in the gauge cell. This can be brought about in

- 2 -

two manners. In the first case, the source of electrons is the thermal emission of electrons from a hot cathode. Such devices are known as hot cathode pressure gauges. In the second case - relating to the so-called cold cathode pressure gauges - the source of electrons is the secondary emission from the cathode, said secondary emission being initiated by bombarding said cathode with ions. Since there are very few such electrons, we entrap them in a trap made by a convenient combination of a transversal electric and magnetic field.

Besides being functionally related to the pressure, the ion current in a cold cathode pressure gauge also depends on the magnetic field and on the source voltage. The magnetic field is generally constant and can not be modified. Likewise, the source voltage of the gauges is always selected so as to be constant, although it could be regulated in order to compensate for the discharge variations, resulting from variations in pressure.

## 2. Background Art

The development of the first cold cathode pressure gauge based on the Penning cell (US 2.197.079) which could only operate up to pressures of around  $10^{-6}$  mbar, and the resulting commercial use of pressure gauges, prompted several patents, which are briefly discussed hereinbelow.

A pressure gauge suitable for measuring pressures in the ultrahigh-vacuum range, which could measure pressures of up to  $10^{-12}$  mbar, was obtained by providing the ions collector with a special protection, thereby reducing the

- 3 -

influence of parasitic currents, which were a consequence of the intense electric field inside the cell (US 3051868).

The problem of weak currents at very low pressures was overcome by employing an additional source of ions (US 5278510). As a source of ions a micropoint cathode is used which is arranged outside of an anode grid, so that electrons can pass into the interior of the anode cylinder and assist the ionization of molecules. The ion current flow is thereby increased and, consequently, easier to measure.

By developing a pressure gauge operating with a constant voltage at low pressures, and with a periodically varying voltage at higher pressures, a wider operating range of pressure measurement was achieved (US 4000457). A pressure gauge of this type can operate even at high pressures of up to  $10^{-1}$  mbar.

Furthermore, a pressure gauge was devised having a magnetic field that varies in direction along the gauge cell's axis, thereby facilitating the ignition of the pressure gauge at low pressures, which likewise broadens the operating pressure range of the pressure gauge (US 5568053).

To shorten the ignition time of the pressure gauge at low pressures, an additional UV light source was introduced, triggering an emission of photoelectrons which, in turn, help initiate the electrical discharge (US 5198772).

In US Pat. No. 4866640 a pressure gauge is disclosed which, in addition to measuring the ion current, also measures the concomitant gas temperature. Said pressure gauge includes a special microprocessor which temperature-

- 4 -

compensates the pressure readout in view of separately stored calibration data.

Prior art cold cathode pressure gauges operate at a constant voltage, which is situated outside of the maximum. For this reason, the ion current is non-linear. Moreover, instabilities and discontinuities often occur, impeding measurement.

It is an object of this invention to provide a method and a device for measuring ultrahigh vacuum and, more particularly, to provide a method for measuring ultrahigh vacuum by means of an ultrahigh-vacuum cold cathode pressure gauge and, as a further object of the invention, to provide an ultrahigh-vacuum cold cathode pressure gauge, that avoids prior art disadvantages, exhibits a better sensitivity, and enables a linear, stable and continuous measurement of pressure in the ultrahigh-vacuum range.

According to the present invention the object is achieved by a method and a device for measuring ultrahigh vacuum according to the independent patent claims.

### 3. Description of the Inventive Solution

The present invention comprises a method and a device for measuring ultrahigh vacuum and, more particularly, a method for measuring ultrahigh vacuum by means of an ultrahigh-vacuum cold cathode pressure gauge, and the related ultrahigh-vacuum cold cathode pressure gauge with varying voltage. The ion current depends on the source voltage and reaches its maximum value at a predetermined voltage. The position of said maximum depends on pressure. The cold cathode pressure gauge according to the invention

- 5 -

operates in such a way that the source voltage varies according to pressure, keeping the ion current at its maximum level at all times. The maximum ion current is directly proportional to the pressure. Said maximum current is stable and presents no discontinuities or oscillations, making pressure readings both more accurate and simpler. In addition, the cold cathode pressure gauge of the invention has a greater sensitivity because it operates at the maximum value.

The invention shall hereinafter be described with reference to the sample embodiment in conjunction with the accompanying drawings, wherein:

Figure 1 is a schematic representation of the cold cathode pressure gauge in accordance with the invention;

Figure 2 shows the typical I(U) characteristic of the gauge at various pressures;

Figure 3 shows a plot of the voltage, at which current is at its maximum value, against pressure; and

Figure 4 shows a plot of the pressure dependence of the maximum ion current.

Figure 1 represents a pressure gauge in accordance with the invention, made of a magnetron cell. The magnetron cell is composed of two electrodes: the anode 1 in the form of a hollow anode cylinder, connected via a high-voltage conductor 2 to a voltage source 3, and the cathode 4 in the form of a cathode rod, disposed along the axis of and internal to the anode cylinder of the anode 1. The anode cylinder of the anode 1 and the cathode rod of the cathode 4, electrically insulated from one another, are enclosed in the housing envelope 5 of the pressure gauge, which is connected by means of a compact flange 6 to the vacuum

- 6 -

system, wherein the pressure is to be established. By connecting the source voltage from a voltage-controlled source 3, a discharge is initiated in the anode cylinder of the anode 1 in the transversal electric field and the external magnetic field 7, oriented along both electrodes, namely, the anode cylinder of the anode 1 and the cathode rod of the cathode 4, in which discharge the ionization of gas molecules takes place, and the resulting ions are accelerated in the electric field within the cell toward the cathode 4. By means of the ammeter 8 the ion current on the cathode 4 is measured, which depends on pressure.

The source voltage of the pressure gauge must be selected carefully, in that the accuracy and sensitivity of said pressure gauge depend upon it. As may be seen in Figure 2, the ion current first increases with voltage, then it reaches a very pronounced maximum value, and ultimately it drops. This characteristic dependence of current on voltage extends over the entire operating pressure range of vacuum gauges. The voltage-controlled source 3 ensures that the ion current of the pressure gauge is at its maximum value at all times. Now, this optimal voltage is not constant, but, in turn, varies with pressure, as shown in Figure 3. The voltage increases roughly monotonously with increase in pressure. Which means that, at higher pressures, the pressure gauge must operate at a higher voltage. If the cold cathode pressure gauge operates in such a way that the current is maintained at its maximum value, said current is a function of the pressure, as shown in Figure 4. Such manner of operation of the pressure gauge is accomplished through employing a voltage-controlled source 3, which may be done in two ways.

- 7 -

The first alternative is to provide the voltage supply - the voltage-controlled source 3 - with a gauge, which preliminarily scans the whole voltage range (preferably between 1 kV and 12 kV) in a short time, and subsequently sets the source 3 to the voltage at which the current was at its maximum value. In this embodiment, therefore, the source 3 is connected to or includes a gauge and is controlled by said gauge so as to operate at a varying voltage.

The other alternative is to employ, based on the calibration of the gauge (in other words, the variation of voltage with pressure being known), a computerized voltage supply that, for a given pressure, will set the voltage to the value that has been previously stored as optimal. The pressure gauge of the invention may be used over the entire pressure range covered by cold cathode vacuum gauges of various types.

Likewise, the pressure gauge according to the invention may be utilized over the whole range of magnetic fields covered by cold cathode vacuum gauges of various types, the preferable range of magnetic field densities being comprised between 0.05 T and 1.5 T. Likewise, the inventive pressure gauge is applicable to other types of cold cathode gauges and to all electrode geometries, including the Penning pressure gauge with an absent cathode and the inverted magnetron gauge with the polarities of the electrodes inverted.

## Patent Claims

1. Method for measuring ultrahigh vacuum by means of an ultrahigh-vacuum cold cathode pressure gauge, characterized in that the voltage on the anode of the pressure cell varies with pressure in such a way that the ion current flow is maintained at its maximum value at all times, wherein the voltage-controlled source preliminarily scans the whole voltage range, preferably between 1 kV and 12 kV, in a short time, and subsequently sets the source to the voltage, at which the current was at its maximum value.
2. Method for measuring ultrahigh vacuum by means of an ultrahigh-vacuum cold cathode pressure gauge, characterized in that the voltage on the anode of the pressure cell varies with pressure in such a way that the ion current flow is maintained at its maximum value at all times, wherein the voltage-controlled source, based on the calibration of the gauge, will set the voltage, for a given pressure, to the value that has been previously stored as optimal.
3. Device for measuring ultrahigh vacuum, wherein the said device is an ultrahigh-vacuum cold cathode pressure gauge, characterized in that the anode (1) of the pressure gauge cell is connected to a voltage-controlled source (3), said source, in turn, being controlled in such a manner that the output voltage of the voltage-controlled source (3)

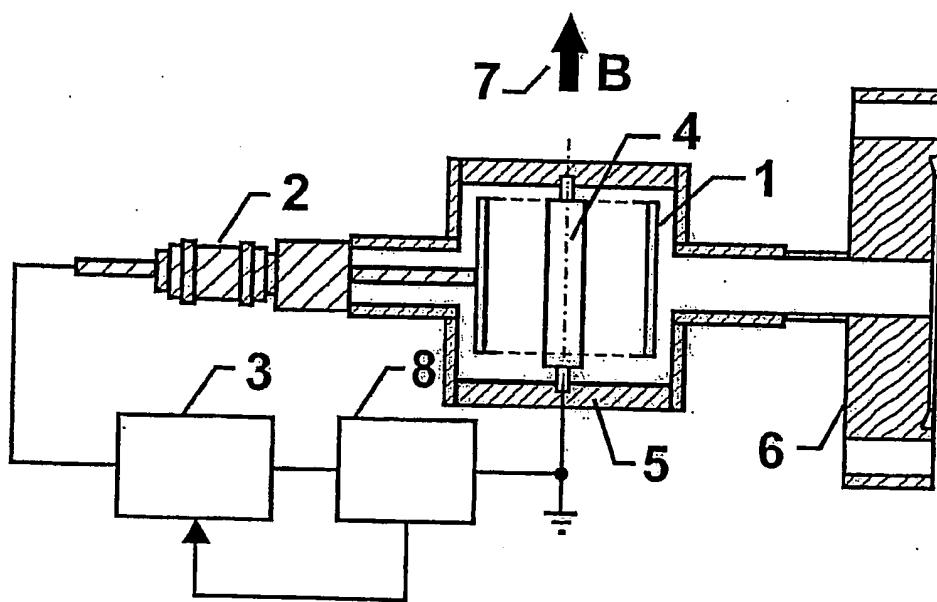
- 9 -

varies with pressure so as to maintain the ion current at its maximum level at all times.

4. Device according to Claim 3, characterized in that the voltage-controlled source (3) by means of the gauge preliminarily scans the whole voltage range, preferably between 1 kV and 12 kV, in a short time, and subsequently sets the source to the voltage, at which the current was at its maximum value.
5. Device according to Claim 3, characterized in that, based on the calibration of the gauge, a computerized source (3) is employed, which will set the voltage, for a given pressure, to the value that has been previously stored as optimal.
6. Device according to Claims 3 to 5, characterized in that the pressure gauge cell is a magnetron pressure gauge cell.
7. Device according to Claims 3 to 5, characterized in that the pressure gauge cell is an inverted magnetron pressure gauge cell.
8. Device according to Claims 3 to 5, characterized in that the pressure gauge cell is a Penning pressure gauge cell.

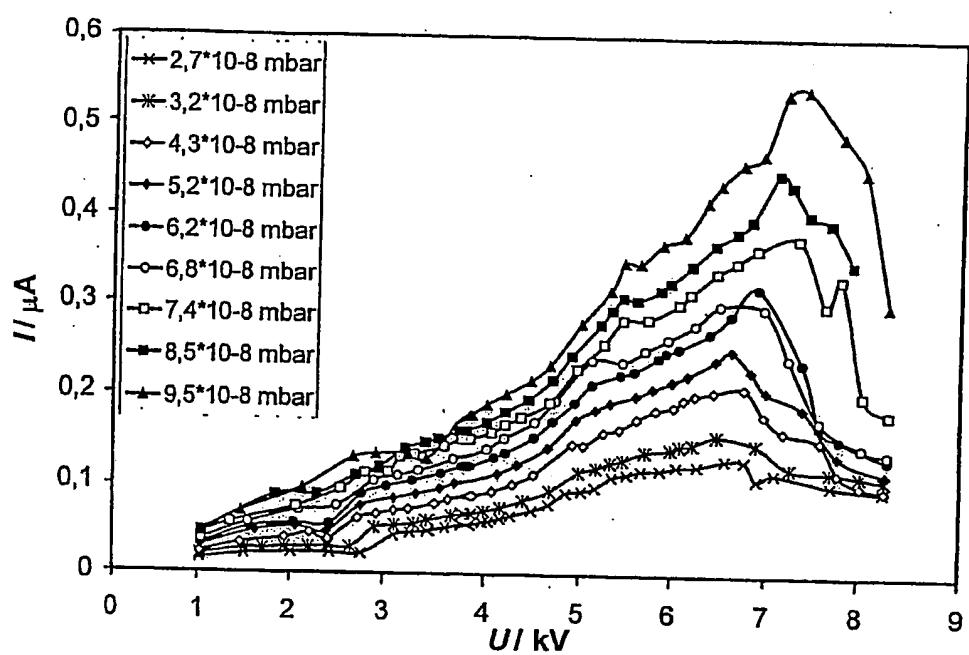
1/4

Fig. 1

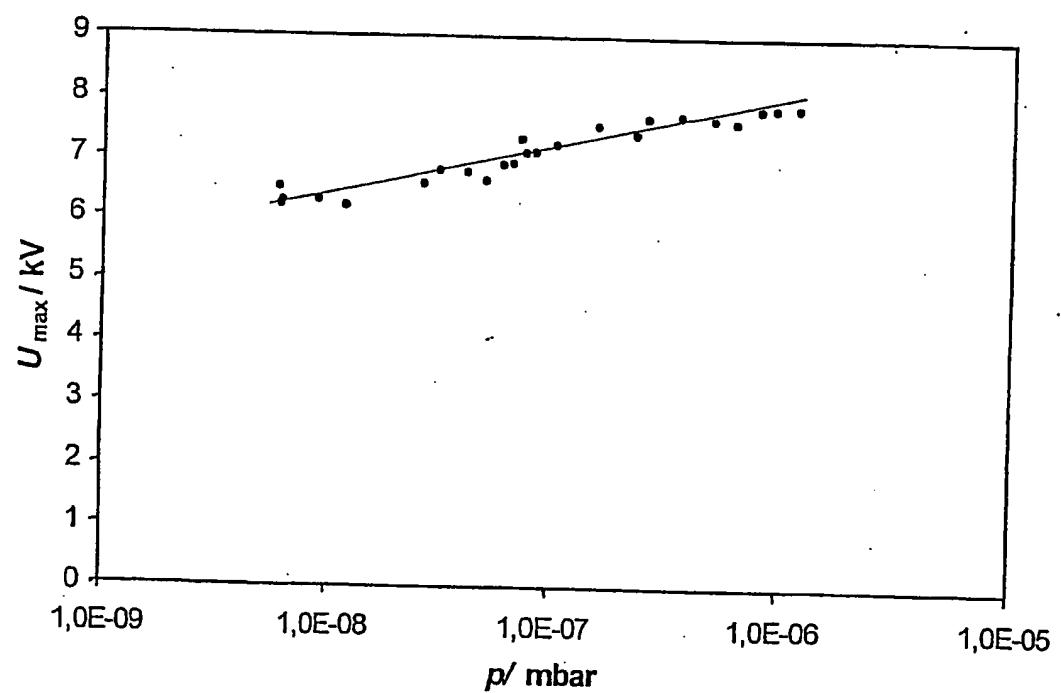


2/4

Fig. 2

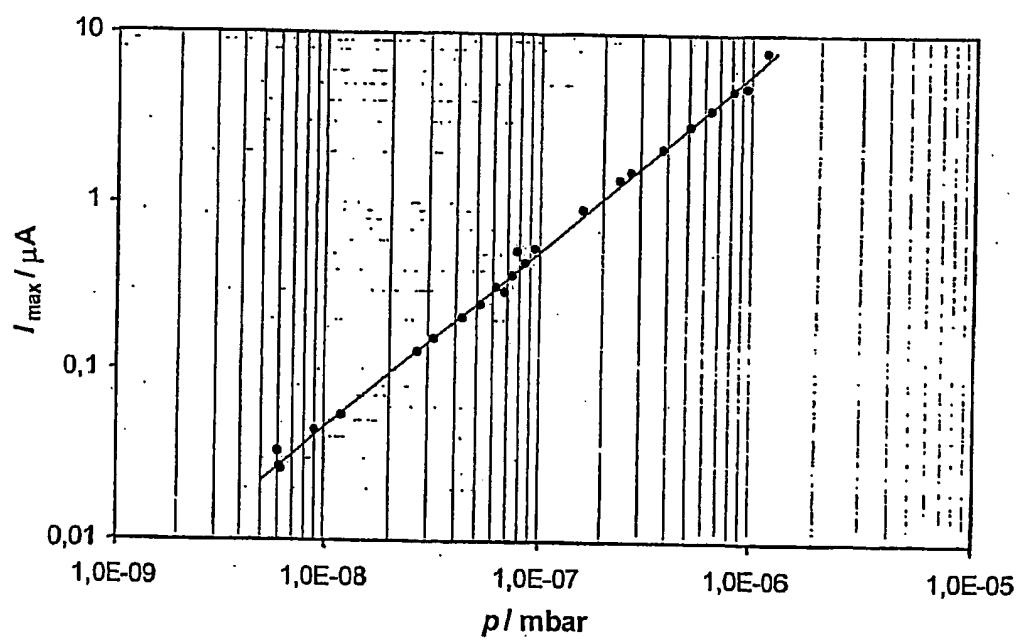


3/4

**Fig. 3**

4/4

Fig. 4



## INTERNATIONAL SEARCH REPORT

International Application No.  
PCT/SI2005/000003

## A. CLASSIFICATION OF SUBJECT MATTER

IPC 7 G01L21/34

According to International Patent Classification (IPC) or to both national classification and IPC

## B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)  
IPC 7 G01L

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the International search (name of data base and, where practical, search terms used)

EPO-Internal, WPI Data

## C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	GB 722 788 A (SIEMENS & HALSKE AKTIENGESELLSCHAFT) 26 January 1955 (1955-01-26) the whole document	1-8

 Further documents are listed in the continuation of box C. Patent family members are listed in annex.

## \* Special categories of cited documents :

- \*A\* document defining the general state of the art which is not considered to be of particular relevance
- \*E\* earlier document but published on or after the International filing date
- \*L\* document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)
- \*O\* document referring to an oral disclosure, use, exhibition or other means
- \*P\* document published prior to the International filing date but later than the priority date claimed

- \*T\* later document published after the International filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
- \*X\* document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
- \*Y\* document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.
- \*Z\* document member of the same patent family

Date of the actual completion of the International search

7 July 2005

Date of mailing of the International search report

26/07/2005

Name and mailing address of the ISA

European Patent Office, P.B. 5818 Patentlaan 2  
NL - 2280 HV Rijswijk  
Tel (+31-70) 340-2040, Tx. 31 651 epo nl  
Fax: (+31-70) 340-3016

Authorized officer

Zafiroopoulos, N

# INTERNATIONAL SEARCH REPORT

International Application No  
PCT/SI2005/000003

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
GB 722788	A 26-01-1955	NONE	

**This Page is Inserted by IFW Indexing and Scanning  
Operations and is not part of the Official Record**

## **BEST AVAILABLE IMAGES**

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- BLACK BORDERS**
- IMAGE CUT OFF AT TOP, BOTTOM OR SIDES**
- FADED TEXT OR DRAWING**
- BLURRED OR ILLEGIBLE TEXT OR DRAWING**
- SKEWED/SLANTED IMAGES**
- COLOR OR BLACK AND WHITE PHOTOGRAPHS**
- GRAY SCALE DOCUMENTS**
- LINES OR MARKS ON ORIGINAL DOCUMENT**
- REFERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY**
- OTHER: \_\_\_\_\_**

**IMAGES ARE BEST AVAILABLE COPY.**

**As rescanning these documents will not correct the image problems checked, please do not report these problems to the IFW Image Problem Mailbox.**